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1. Introduction

The highest critical transition temperature ($T_c$) among all the intermetallic superconductors is that was discovered MgB$_2$ has changed the previous approaches to the theory of superconductivity because the $T_c$ limit in metallic superconductors had been believed to be $ \sim 30 \text{ K}$, which is predicted by the Bardeen-Cooper-Schrieffer (BCS) theory [1]. In the BCS theory of superconductivity [2, 3], the expression for $T_c$ is derived as $T_c = \theta_D (1/\lambda_{\text{eff}})$, where $\theta$ is always equal to the MgB$_2$ Debye temperature, $\theta_D$. $\lambda_{\text{eff}}$ is defined as the electron and phonon coupling constant $\lambda = N(E_F) \times V$, where $N(E_F)$ is the normal state electron number density the Fermi surface, and $V$ is the average electron interaction matrix element corresponding to the attraction. A weak coupling, $\lambda \ll 1$, is assumed to exist between the electrons and phonons in the initial BCS theory. In this case, the value of $T_c$ is limited to $T_c \approx 30 \text{ K}$. According to the BCS theory, an element or compound with larger $N(E_F)$, $V$, and $\theta_D$ has high $T_c$ value. However, $\theta_D$ of MgB$_2$ is comparable to those of other diborides and other light materials. Furthermore, the $N(E_F)$ is relatively low because of the absence of $d$-electrons. Thus, the unusually high $T_c$ in MgB$_2$ has confused researchers with respect to the origin of its superconductivity. Considerable theoretical and experimental work has been conducted to explore the superconducting mechanism in MgB$_2$.

MgB$_2$ is the first superconductor to be proved to have two distinct superconducting gaps in its superconducting state [4]. Initially, an unconventional exotic superconducting mechanism was suggested for the material [5, 6]. Then, other researchers proposed hole superconductivity, which is similar to what occurs in high temperature superconductors (HTS), based on the fact that holes are the dominant charge carriers in the normal state [7, 8]. MgB$_2$ has now been accepted as a phonon-mediated BCS type superconductor. The superconductivity is attributed to selective coupling between specific electronic states and specific phonons, such as the $E_{2g}$ mode. The unusually high $T_c$ value arises from the strong phonon anharmonicity.
Choi et al. have calculated the phonon frequencies and electron-phonon interactions from frozen phonon calculations at all the symmetry points of the Brillouin zone [9]. Six non-acoustic modes at the Brillouin zone centre $\Gamma$ are divided into four distinct phonon modes based on the point symmetry of the lattice. The two vibrations along the $c$-axis are singly degenerate modes of $A_{2u}$ and $B_{1g}$. For the $A_{2u}$ mode, both Mg and B move in opposite directions along $c$. For $B_{1g}$, the B atoms move in opposite directions, while the Mg is stationary. The other two modes along the $x$ or $y$ directions involving only in-plane motions are doubly degenerate. The vibration of Mg and B planes in opposite directions along the $x$ or $y$ directions is $E_{2g}$ mode. Mg atoms are stationary in the $E_{2g}$ mode, while B atoms exhibit a breathing vibration in the $x$ or $y$ directions. This mode is highly anharmonic. The theoretical vibration energy of the $E_{2g}$ mode is around 75 meV [10, 11], which is in agreement with the results from Raman measurements [12, 13].

MgB$_2$ is easy to make into bulk, wire, tape, and thin film forms. However, the critical current density ($J_c$) of pristine MgB$_2$ drops rapidly in high magnetic field due to the weak pinning forces and low upper critical field ($H_{c2}$). Many techniques have been employed to improve the application potential of MgB$_2$ such as chemical doping, irradiation, thermo-mechanical processing, and magnetic shielding. Although the critical current density, upper critical field, and irreversibility field ($H_{irr}$) have been greatly increased [14], many difficulties need to be overcome for further application. The origin of the flux pinning force and relevant fabrication techniques will be discussed in this work. Lattice distortion is found to be one of the most effective sources of flux pinning centers in pure MgB$_2$. Then, the combined effects of connectivity and lattice disorder on the flux pinning force are investigated based on nanosize SiC doped MgB$_2$.

The depairing current density, $J_d$, can be estimated from the Ginzburg-Landau (GL) formula:

$$J_d = \Phi_0 / \left[ 3 / (\sqrt{3}) \pi \mu_0 \lambda^2 (T) \xi(T) \right],$$

(1)

where $\Phi_0$ is the flux quantum, $\mu_0$ the permeability of vacuum, $\lambda$ the penetration depth, and $\xi$ the coherence length [15]. However, it is not the theoretical maximum [16]. With the help of optimized pinning, about 15% of $J_d$ can be obtained at low magnetic fields in superconductors [17, 18]. The high field values for pure MgB$_2$ are $\lambda = 80$ nm and $\xi = 12$ nm, respectively. $J_d$ at zero K is estimated as $\sim 1.3 \times 10^8$ A.cm$^{-2}$. The contribution from $\pi$-band charge carriers to the depairing current density is quite low, only about 10% [16], and the interaction energy induces the difference from the high field value. The depairing current is reduced in samples with defects because of the increased $\lambda$ values [18].

The grain boundaries in MgB$_2$ do not show the weak link effect, and clean grain boundaries are not obstacle to supercurrents [19, 20]. On the other hand, dirty grain boundaries do potentially reduce the critical current [21]. Insulating phases on the grain boundaries, such as MgO, boron oxides [22] or boron carbide [23], normal conducting phases [24], porosity, and cracks [25], can further reduce the cross-section effective of supercurrents. The high porosity in in-situ prepared MgB$_2$ is responsible for its low density, only about half (or less) of its theoretical value [26].
The concept of connectivity, $A_{\text{con}}$, has been introduced to quantify the effective cross-sectional ($\sigma_{\text{eff}}$) for supercurrents [21, 27]: $A_{\text{con}} = \sigma_{\text{eff}} / \sigma_0$ where $\sigma_0$ is the geometrical cross-section. The connectivity is estimated from the phonon contribution to the normal state resistivity through $A_{\text{con}} = \Delta \rho_{\text{theo}} / \Delta \rho_{\text{exp}}$ with $\Delta \rho_{\text{theo}} \approx 9 \mu\Omega \text{cm}$. This estimate is based on the assumption that $\sigma_{\text{eff}}$ is reduced equivalently in the normal and superconducting state [18]. The supercurrents are limited by the smallest effective cross-section along the conductor. A single large transverse crack can reduce strongly $J_c$ while only slightly increases the resistivity of a long sample. Unreacted magnesium decreases $\Delta \rho_{\text{exp}}$ [28] and the effective paths for supercurrents. The thin insulating layers located on grain boundaries can decrease the effective connectivity $A_{\text{con}}$, inducing high $\Delta \rho_{\text{exp}}$ although this kind of defect is transparent to supercurrents. The $\Delta \rho_{\text{theo}}$ values within the grains depend on the defects and strain in the grains. Sharma observed negative $\Delta \rho_{\text{exp}}$ in highly resistive samples [29]. Despite these objections, $A_{\text{con}}$ is very useful for estimating the connectivity of samples if the resistivity is not too high. A clear correlation between the resistivity and the critical current was found in thin films [27]. It should be noted that this procedure is not always reliable, although it offers a possibility for understanding the influences of the connectivity on the supercurrent [18].

The in-situ route is a practical technique to improve the $H_c2$ and $J_c$ performance of MgB$_2$ using magnesium or MgH$_2$ as the precursor material [30-39], which reacts with boron after mixing and compacting. Low annealing temperature generates MgB$_2$ samples with small grains [25, 40-52] due to the poor crystallinity, and the great amount of grain boundaries result in strong pinning and high $H_c2$. Magnesium deficient samples can be fabricated by adjusting the stoichiometry of the precursor materials. This method can generate strong lattice strain in MgB$_2$, which decreases $T_c$ and increases $H_c2$ [44, 53-56]. On the other hand, an excess magnesium ratio in the raw materials can compensate for the evaporation loss of Mg due to its low melting temperature and the reaction loss due to the reaction with oxygen or the sheath material. The morphology and particle size of the precursor magnesium powders are crucial for the superconductivity and superconducting performance of the final MgB$_2$ [57]. The grain size of the initial boron powder also has a significant influence on the MgB$_2$ samples. Some researchers have employed ball milling and mechanical alloying of the magnesium and boron mixture, reducing the grain size and enhancing the critical supercurrent [55, 58-65].

The reaction kinetics between magnesium and boron can be modified by chemical or compound dopants [66], which influence the grain shape and size [67, 68], the secondary phases [69], MgB$_2$ density [70], and the element stoichiometry [71]. Carbon doping is one of the most promising methods to improve the superconducting performance of MgB$_2$. The carbon sources include B$_4$C [72, 73], carbon [52, 66, 67, 74], carbon nanotubes [75-78], nanodiamonds [78, 79], NbC [80], SiC [41, 51, 57, 66, 72, 81-89], and organic compounds [39, 47, 90]. SiC is one of the most promising dopants because it can react with magnesium and boron to form C doped MgB$_2$ at quite low temperatures (600 °C), based on the dual reaction model [66]. Higher processing temperatures are necessary for most of the other carbon sources, leading to grain growth and worse pinning. Comparable results to those with SiC have also obtained, however, with nanoscale carbon powder [91], stearic acid [92], and carbon nanotubes [76].
The in-situ technique also suffers from its disadvantage of low mass density, which is originates from the annealing process, because the precursor powder has a lower density than MgB$_2$. High pressure synthesis increases the density [93, 94]. On the other hand, the density of ex-situ materials is usually close to the real density of MgB$_2$ [94] and can be further improved by hot isostatic pressing (HIP) [91, 95, 96]. However, the grain size of ex-situ produced materials is comparatively large and inhomogeneous due to the post annealing [97, 98]. Small grains (~100–200 nm) have also been reported [99]. A high temperature heat treatment is necessary for the ex-situ process to improve the connectivity [99-102]. This heat treatment leads to recrystallization and $H_{c2}$ reduction [25]. It is concluded that disorder induced by the low temperature processing is insufficient for high superconducting performance of the ex-situ MgB$_2$. Furthermore, thermally stable defects, such as dopants, are necessary for enhancing the high field performance [18].

2. Thermal-strain-induced high $J_c$ in high density SiC-MgB$_2$ bulk

The connectivity is considered to be a critical issue for improving the $J_c$ of MgB$_2$ based superconductors. Furthermore, an efficient flux pinning force is crucial for high magnetic field application. Here, we employed an in-situ diffusion process to make high density MgB$_2$ bulks and investigate the efficiency of the high flux pinning force induced by lattice thermal strain [103]. Microstructural analysis and Raman scattering measurements were employed to investigate the origins of the huge flux pinning force. Doping nano-SiC particles into MgB$_2$ has been proven to be particularly effective in significantly enhancing $J_c$, $H_{irr}$, and $H_{c2}$ [14, 104, 105]. In contrast to chemical doping effects, tensile stress is believed to act as a source of strong flux pinning centers when there is no reaction between SiC and MgB$_2$. Both the $J_c$ and $T_c$ are improved by thermal strain on the interface between SiC and MgB$_2$ during the diffusion process [106] and hybrid physical-chemical vapor deposition (HPCVD) [107]. The influences of the stress field on the flux pinning force and the electron-phonon coupling constant are discussed to clarify the superconducting performance of high density SiC-MgB$_2$ composite fabricated through the diffusion method.

Crystalline B with 99.999% purity was pressed into pellets or mixed with 10wt% SiC particles and then pressed into pellets. The pellets were sealed in iron tubes and padded with 99.8% Mg powder. The Mg to B atomic ratio was 1.15:2.0. The diffusion process is time dependent. The sintering condition were 1123 K for 10 h under a flow of high purity argon gas to achieve fully reacted MgB$_2$ bulks. Then the samples were cooled down to room temperature. X-ray diffraction (XRD) was employed to characterize the phases, and the results were refined to determine the $a$-axis and $c$-axis lattice parameters and the lattice distortion. Microstructure observations were performed with a transmission electron microscope (TEM). The magnetic $J_c$ was derived from the height of the magnetization loop $\Delta M$ using the Bean model: $J_c = \frac{15\Delta M}{\pi a^2 h}$, where $a$ and $h$ are the radius and height of a cylindrical sample. The $T_c$ value could be deduced from the temperature dependence curve of the magnetic susceptibility $M(T)$. To observe the temperature effects of lattice strain, Raman spectra were collected using a confocal laser Raman spectrometer (Renishaw inVia plus) under a 100× microscope. The excitation laser is Ar+ 514.5 nm.
The density of the pure MgB$_2$ sample is about 1.86 g/cm$^3$, which is about 80% of the theoretical density. This value is much higher than those of the samples made by the in-situ process, which were less than 50%. The SiC-MgB$_2$ composite shows an even higher density of 1.91 g/cm$^3$ due to the SiC addition. Figure 1 shows the Rietveld refinement XRD patterns of the pure MgB$_2$ and the 10wt% SiC doped MgB$_2$ samples. In this case, SiC did not react with magnesium and boron to form C doped MgB$_2$ and Mg$_2$Si. The product is a SiC-MgB$_2$ composite. The Rietveld refinement analysis indicates that the unreacted SiC content was about 9.3wt%, similar to the SiC content in the precursor. This is consistent with the absence of Mg$_2$Si in the XRD pattern as shown in Figure 1. The result is different when the SiC-doped MgB$_2$ prepared by the in-situ technique [14, 41, 84], in which only a very small amount of SiC remains, while Mg$_2$Si is always present due to the reaction of Mg with SiC. The $a$- and $c$-axis lattice parameters were 3.0850 Å and 3.5230 Å for pure MgB$_2$, and 3.0840 Å and 3.5282 Å for SiC doped MgB$_2$, respectively. The $a$-axis parameters are virtually equivalent for the two samples, whereas the $c$-axis one is slightly stretched in the SiC-MgB$_2$ composite. The phenomenon is different from the shortening of the $a$-axis parameter in in-situ processed SiC doped MgB$_2$ while the $c$-axis parameter remains unchanged [14, 89].

To explain the abnormal $c$-axis enlargement of the SiC-MgB$_2$ composite, the thermal expansion coefficients, $\alpha$, of MgB$_2$ and SiC are considered. It is reasonable to assume that both the MgB$_2$ and the SiC are in a stress-free state at the sintering temperature of 1123 K due to the relatively high sintering temperature over a long period of time. However, the lattice parameters are determined by the thermal strain during the cooling process. The temperature dependences of the $\alpha$ values for MgB$_2$ and SiC are especially different. Figure 2(a) plots the $\alpha(T)$ for MgB$_2$ and SiC along the $a$- and $c$-axes, based on the data of References [108-111]. It clearly shows the weak temperature dependence of $\alpha(T)$ for SiC in both directions, whereas the changes are great for MgB$_2$ and are characterized by high anisotropy. The averaged $\alpha(T)$ is also huge in MgB$_2$ as

![Figure 1](image-url)
shown in the inset of Figure 2(a). The $\alpha_{\text{SiC}}$ decreases slightly from $5 \times 10^{-6}$/K at 1123 K to $2.5 \times 10^{-6}$/K at 0 K, whereas the $\alpha_{\text{MgB}_2}$ drops quickly from $1.7 \times 10^{-5}$/K at 1123 K to zero at 0 K. Based on $\alpha(T)$, the normalized lattice change and lattice strain in the MgB$_2$ matrix of SiC-MgB$_2$ composite during cooling from 1123 K to 0 K can be derived, as shown in Figure 2(b). An assumption of Figure 2(b) is that the two phases are strongly connected and the volume shrinkage of MgB$_2$ is confined by the relatively stable SiC. The normalized lattice strain is estimated to be -0.55% in SiC-MgB$_2$ along the $c$-axis at room temperature. The negative value corresponds to tensile strain in the MgB$_2$. The large $c$-axis strain in the doped MgB$_2$ results in an enlargement in the $c$-axis by 0.15 % in comparison with pure MgB$_2$. As estimated from the Williamson-Hall model [112], the lattice strain is 0.208 and 0.306 along the $a$-axis, and 0.292 and 1.13 along the $c$-axis for pure and SiC-MgB$_2$, respectively. The lattice strain along the $c$-axis in the SiC-MgB$_2$ has increased from that of pure MgB$_2$ by a factor of 4, which is attributed to the high anisotropy in the thermal expansion coefficient of MgB$_2$.

Figure 3. (a) Bright field TEM image of the pure MgB$_2$ with indexed SAD pattern (inset). (b) High resolution electron microscope (HREM) image of interface in pure MgB$_2$ with FFT pattern along the [100] axis (inset). (c) Bright field TEM image of SiC-MgB$_2$. (d) HREM image of interface in SiC-MgB$_2$ and FFT patterns of SiC and MgB$_2$ from each side of the interface. The dashed line shows the interface of SiC and MgB$_2$. 
The unreacted SiC buried in the MgB$_2$ matrix is believed to be one of the most effective sources of strain, and the strongly connected interfaces of SiC and MgB$_2$ are the most effective flux pinning centers. The micro morphologies can be detected using TEM to explore the defects and grain boundaries both in the pure MgB$_2$ and in the SiC-MgB$_2$. Figures 3(a) shows a bright field image of pure MgB$_2$. A high density of defects, such as dislocations and lattice distortion, is observed in the MgB$_2$ phase, and the grain size is about 100 nm, as estimated from the grain boundaries. In contrast to with the highly porous structure in the MgB$_2$ samples [91], the samples made by the diffusion process are well connected with high density. The indexed selected area diffraction (SAD) image shows very pure polycrystalline MgB$_2$. A high resolution grain boundary image is shown in Figure 3(b). The interface is very clean and well connected. The indexed fast Fourier transform (FFT) pattern indicates that the right part parallels the (1 1 0) plane. The micro structure of SiC-MgB$_2$ is similar with that of pure MgB$_2$ with high density of defects. Furthermore, nanosize SiC particle are detected in the MgB$_2$ matrix as indicated in Figure 3(c). Figure 3(d) shows the interface of SiC and MgB$_2$. Based on the FFT analysis, the interface is marked with a dashed line on the image. The left side is a SiC grain paralleling the (1 0 1) plane and the right side is a MgB$_2$ grain paralleling the (0 0 1) plane. This kind of interface will impose tensile stress along the c-axis in MgB$_2$ because the thermal expansion coefficient for MgB$_2$ is highly anisotropic in the [001] direction, while that for SiC is nearly isotropic, which is responsible for the enlarged c-axis of MgB$_2$.

Figure 4. The magnetic $J_c$ versus field at 5 K, 20 K, and 30 K for pure and nano-SiC doped samples. The inset shows the superconducting transitions of the two samples [103].

Based on the collective pinning model, [113], $J_c$ is independent of the applied field in the single-vortex pinning regime (low magnetic field region: $H < H_{sb}$), where $H_{sb}$ is the crossover field from single-vortex to small-bundle pinning. The $J_c$ decreases exponentially in the small-bundle regime (high magnetic field: $H_{sb} < H < H_{irr}$). According to the dual model [14], the significant
effect of SiC doping on $J_c$ comes from the high level of C substitution on the B planes, which is responsible for the reduction of the self-field $J_c$ [104, 105]. However, the SiC-MgB$_2$ composite sample shows not only an improved in-field $J_c$ but also no degradation in self-field $J_c$ as indicated in Figure 4. The approximate $H_{ab}$ values are also indicated on the $J_c$ curves for 20 K and 30 K, although $H_{ab}$ has not been detected at 5 K due to the relatively high supercurrents. The in-situ processed SiC doped MgB$_2$ normally shows a decrease in $T_c$ of 1.5 to 2 K [14, 104, 105], but this present SiC-MgB$_2$ composite sample features a small drop of 0.6 K, as shown in the inset of Figure 4. This phenomenon is attributed to the absence of any reaction between Mg and SiC, as well as the stretched MgB$_2$ lattice, as indicated by the XRD pattern [107].

To investigate whether the lattice strain is significant in SiC-MgB$_2$ during low temperature measurements to obtain $M(H)$ and $M(T)$ curves, Raman spectra were collected before and after the measurements. The Raman spectra for the pure MgB$_2$ are shown in Figure 5(a) and (b) to compare the cooling effects on the matrix. Both the spectra have been fitted with three peaks: $\omega_1$, $\omega_2$, and $\omega_3$ [114-116]. Based on the previous results, $\omega_2$ is the reflection of the $E_{2g}$ mode at the $\Gamma$ point of the Brillouin zone in the simple hexagonal MgB$_2$ structure (space group: $P6/mmm$), while $\omega_1$ and $\omega_3$ come from the lattice distortion. The effects of $\omega_3$ are not discussed in the following analysis because of its small influence on the spectra. As indicated by the fitting parameters that are shown in Figure 5, both the peak centers and the full width at half maximum (FWHM) values show negligible differences before and after the low temperature measurements because of synchrotron volume fluctuation. The weak temperature dependence of the Raman spectra for pure MgB$_2$ in agreement with the results of Shi et al [117]. The $\omega_2$ peak of the Raman spectrum of SiC-MgB$_2$ before the low temperature measurement has shifted to the low frequency of 585 cm$^{-1}$, as shown in Figure 6(a). The FWHM of the $\omega_2$ peak increases from ~200 cm$^{-1}$ to 210 cm$^{-1}$. Furthermore, the FWHM of the $\omega_3$ peak increases from ~93 cm$^{-1}$ to 125 cm$^{-1}$. The variations in both the Raman shift and the FWHM indicate strong lattice strain in the SiC-MgB$_2$ composite. Figure 6(b) shows the cooling effect on the Raman spectrum of SiC-MgB$_2$. The FWHM of the $\omega_2$ peak further increases to 228 cm$^{-1}$, and the frequency of the $\omega_3$ peak shifts to 770 cm$^{-1}$. These results suggest that the stress field is very strong during the low temperature measurements in the SiC-MgB$_2$ composite. Considering the stable defect structures in the sample at room temperature and the measurement temperatures, the high $J_c$ performance is attributed to the thermal strain. Although the interface or grain boundaries themselves are effective flux pinning centers, the thermal strain provides more efficient flux pinning force, based on the comparison of the $J_c$ values in pure the MgB$_2$ and the SiC-MgB$_2$ composite.

It should be noted that the broadened $\omega_2$ peak in SiC-MgB$_2$ is a signal of strong electron-$E_{2g}$ coupling, which is responsible for the high $T_c$ in MgB$_2$. The electron-$E_{2g}$ coupling constant is estimated from the Allen equation [118]: $\Gamma_2 = 2\pi \lambda_{E_{2g}} N(0) \omega_{E_{2g}}^2$, where $\Gamma_2$ is the $\omega_2$ linewidth, $\lambda_{E_{2g}}$ is the strength of the electron-$E_{2g}$ coupling, and $N(0)$ is the density of states on the Fermi surface. The experimental phonon frequency and linewidth are simply and directly related to the electron-phonon coupling constant (EPC), $\lambda_{E_{2g}}$. The total density of states (DOS) at the Fermi energy, $E_F$, of pure MgB$_2$ is taken as 0.354 states/eV/cell/spin. The $\sigma$ band contribution is 0.15 and the $\pi$ band is 0.204 [119]. $N(0)$ is assumed to be constant for the small changes of electrons.
and holes in MgB$_2$ and SiC-MgB$_2$. Taking the fitting values of the $\omega^2$ peaks with cooling effects, the $\lambda_{E_{2g}}$ values for the pure MgB$_2$ and SiC-MgB$_2$ are 2.327 and 2.706, respectively. The $\lambda_{E_{2g}}$ of SiC-MgB$_2$ is just slightly higher than that of the pure MgB$_2$. However, the $T_c$ of SiC-MgB$_2$ is slightly decreased compared to that of the pure MgB$_2$. The total EPC constants are degraded by the scattering effects of SiC impurities in the MgB$_2$ matrix, which can be estimated with the McMillan formula [120], as modified by Allen and Dynes:[121] $T_c = \frac{\langle \omega_{\text{ph}} \rangle}{1.2} \exp \left( \frac{-1.04(1 + \lambda)}{\lambda - \mu^* (1 + 0.62\lambda)} \right)$, where $\langle \omega_{\text{ph}} \rangle = (390 \times \omega^2_{E_{2g}} \times 690)$ is the averaged phonon frequency [122], with 390 and 690 cm$^{-1}$.
being the phonon frequencies of the other modes in the MgB$_2$ system [123], $\mu^*$ is the Coulomb pseudopotential, taken as equal to 0.13 [124], and $\lambda$ is the total EPC constant. Taking these values, $\lambda$ is calculated as 0.888 in pure MgB$_2$ and 0.886 in SiC-MgB$_2$, respectively. Although the values are very similar, the $\lambda$ of MgB$_2$ is a little higher because of its low impurity scattering effects. It should be noted that the $\lambda$ values were overestimated using the McMillan formula for the two-gap nature of MgB$_2$. However, the overestimations do not change the dependence of $\lambda$ on the strain effect due to the main contribution of the $\sigma$-band. The residual resistivity of SiC-MgB$_2$ is 16 $\mu\Omega$ cm, but it is just 12 $\mu\Omega$ cm for pure MgB$_2$ due to the weak impurity scattering effects.

In summary, the thermal strain originating from the interface of SiC and MgB$_2$ is one of the most effective sources of flux pinning centers to improve the supercurrent critical density. The weak temperature dependence of the thermal expansion coefficient of SiC stretches the MgB$_2$ lattice as the temperature decreases. The thermal strain supplies much more effective flux pinning force than the interfaces and grain boundaries themselves. The low temperature effects on Raman spectra include very strong lattice stretching at the application temperature of MgB$_2$, which has benefits from both the $J_c$ and the $T_c$ behaviors.

3. High connectivity MgB$_2$ wires fabricated by combined in-situ/ex-situ process

The self-field critical current density, $J_c(0)$, of MgB$_2$ is much higher than for pure or doped samples processed with in-situ annealing [75, 81, 125-128]. $J_c(0)$ values have been reported as high as $3.5 \times 10^7$ A/cm$^2$ at 4.2 K and $1.6 \times 10^8$ A/cm$^2$ at 2 K in highly connected thin films made by HPCVD [129, 130]. The connectivity is much lower than the theoretical value in in-situ MgB$_2$ because the technique involves a liquid-solid phase reaction process with considerable shrinkage due to the high density of MgB$_2$ compared to the powder mixture of Mg and B [104, 115]. Although the diffusion process could increase the $J_c$ of bulk samples, the $J_c(0)$ and disorder of wires and tapes cannot be improved using similar methods. Several research groups have reported possible techniques to increase the connectivity of in-situ filamentary tapes. High pressure sintering and cold high pressure densification (CHPD) can make it possible to fabricate high density wire and tape samples [96, 131, 132]. Nevertheless, neither HIP nor CHPD are suitable for long MgB$_2$ wires and tapes, and the $J_c$ values are still lower than needed for practical application. Kováč et al. reported a mixed in-situ/ex-situ process to make MgB$_2$ wires, and it was found that the $J_c$ was increased when the ex-situ powder ratio were 23% and 50% [133]. They used commercial MgB$_2$ powder from Alfa Aesar in this process with a very wide grain size distribution ranging from submicrometer size up to 100 $\mu$m. In this work, high quality home-made ex-situ powder was used to repeat the mixed in-situ/ex-situ process to develop MgB$_2$/Fe wires with high connectivity and strong disorder to increase both the low and high field $J_c$ properties [134]. The home-made powder was fabricated through low temperature annealing, and the particle size was homogeneous and as small as ~200 nm. The $J_c$ dependence on microstruc-
ture, connectivity, and disorder in MgB$_2$ wires was analyzed based on the microstructure observations.

MgB$_2$ wires were fabricated by the powder-in-tube (PIT) process using a ball-milled mixture of Mg (99%) and amorphous B (99%). The in-situ wires were sintered at 750, 850, 950, and 1050 °C for 30 min in high purity Ar and marked as 750in, 850in, 950in, and 1050in, respectively. The in-situ MgB$_2$ powder was sintered at 650 °C for 30 min in high purity Ar flow and then ball-milled. Then the PIT method was employed to fabricate in-situ/ex-situ combined MgB$_2$/Fe wires using 1:3 ratio of precursor powders to form a mixture of Mg and B powders. All the green wires were annealed at 750, 850, 950, and 1050 °C for 30 min in high purity Ar and marked as 750inex, 850inex, 950inex, and 1050inex, respectively.

The phases and microstructure were characterized by XRD (D/max-2200) and field emission gun scanning electron microscopy (FEG-SEM: JSM-6700F) at room temperature. The superconducting properties were detected from 5 K to 305 K using a Physical Properties Measurement System (PPMS: Quantum Design). The critical superconducting transition temperature, $T_c$, is defined as the onset point on the magnetic moment vs. temperature curve, $M(T)$, measured in a magnetic field of 25 Oe. The magnetic $J_c$ was derived from the Bean model. The resistivity dependence on applied magnetic field and temperature, $\rho(H, T)$, was measured using the four-probe method with $H$ from 0 T to 13 T applied perpendicularly to the current direction, from 5 K to 305 K. $H_{c2}$ and $H_{irr}$ were defined as the magnetic field values at 90% and 10% on the superconducting transition on the $\rho(H, T)$ curve, respectively. The active connectivity factor, $A_F$, was calculated based on the $\rho(H, T)$ behavior.

According to the indexed XRD patterns, the samples contain a small amount of MgO. The MgO contents are high in 950in, 1050in, and 1050inex compared with the other samples. The broad

Figure 7. $T_c$ dependence on sintering temperatures. The insets display the normalized magnetic moment dependence on measurement temperature for in-situ samples (upper) and for combined in-situ/ex-situ samples (lower) [134].
transition widths from the normal state to the superconducting state of these samples confirm
the high impurity contents, as shown in the insets of Figure 7. The 1050in transition width is
~7 K compared with the width of ~2 K for the other samples, which is attributed to the degraded
connectivity of the magnetic flux due to the high MgO content. The in-situ sintered samples
show higher $T_c$ values by 0.5 – 1 K compared with the in-situ/ex-situ ones. The $T_c$ of 1050in
is similar to that of 1050inex because of the high amount of impurity phase. Ball milling of
the raw materials induces a great amount of defects in the in-situ/ex-situ samples, which display
lower $T_c$ compared with the in-situ samples [135, 136]. The connectivity of the in-situ/ex-situ
samples is worse than those of the in-situ samples judging from their big transition widths.
The low amount of Mg evaporation may be responsible for the narrow transition width of
1050inex compared with that of 1050in because the stable precursor MgB$_2$ and low quantity of
Mg in the raw materials reduce the magnesium loss during the sintering at 1050 °C.

Typical SEM images of the in-situ samples are shown in Figure 8. The grain size of 750in is
about 300 nm, and the grains show an isolated distribution due to independent growth. 850in,
950in, and 1050in have big clusters of grains because the increasing sintering temperatures
have extended the crystal growth time. Some clusters are as big as 1 μm in 1050in. The
crystallinity is enhanced at higher sintering temperatures. A high sintering temperature
induces raw magnesium evaporation and MgO formation, which can be observed as small
white particles without contrast under SEM in 1050in.

The crystal shapes for the in-situ/ex-situ samples are irregular with a dispersed distribution of
grain sizea, as shown in Figure 9. The grain size of 750inex is small because of the low sintering
temperature. The recrystallization effect is triggered for 850inex, 950inex, and 1050inex, and
big grains as large as 1 μm are observed. 1050in and 1050inex show similar microstructures
because the high sintering temperature provides enough energy and a long time for the crystal
growth.

Figure 8. SEM images for the in-situ samples sintered at (a) 750 °C, (b) 850 °C, (c) 950 °C, and (d) 1050 °C. The crystal
growth was improved gradually with increasing sintering temperature.

Figure 10 compares the $J_c$ dependence on applied magnetic field measured at 5 K and 20 K.
The $J_c$ value of 1050in is the worst because of the high MgO content. The $J_c$ performances of
750in, 850in, 750inex, and 1050inex are quite similar over the whole field range. While the \( J_c \) deteriorated in 950in and 1050in under higher magnetic fields. 850inex and 950inex show amazingly high \( J_c \) properties. The \( J_c \) values at 5 K under 8 T magnetic field are around five times higher than those of the best in-situ samples. The inset of Figure 10 compares the low field performances measured at 20 K. The in-situ samples, except for 1050in, show competitive low field \( J_c \). The high crystal quality of 950in is of benefit for its high self-field \( J_c \) performance. 750inex and 850inex show low self-field \( J_c \) values. While 950inex and 1050inex display improved \( J_c \), the values are lower than the self-field \( J_c \) of 950in due to the high MgO contents.

The \( J_c \) performance depends on the flux pinning mechanism under different magnetic field intensities. The collective pinning model classifies the disorder-induced spatial fluctuations in the vortex lattice into three regimes based on the strength of the magnetic field: e.g. single-vortex, small-bundle, large-bundle, and charge-density-wave type relaxation of the vortex lattice [113]. The practicable \( J_c \) of MgB2 falls into the single-vortex pinning region and the small-bundle pinning region in the phase diagram. The connectivity determines the \( J_c \) performance in the single-vortex pinning regime because the effective charge carrier density is responsible for the self-field \( J_c \), while \( H_{c2} \) and \( H_{irr} \) are responsible for the \( J_c \) performance in the small-bundle regime based on the disorder or defects.

Figure 9. SEM images for the combined in-situ/ex-situ samples sintered at (a) 750 °C, (b) 850 °C, (c) 950 °C, and (d) 1050 °C. The grains are inhomogeneous due to the ball milled MgB2 precursor and the recrystallization effects.

Figure 10. \( J_c \) dependence on applied magnetic field at 5 K and 20 K. The inset compares the self-field \( J_c \) behavior at 20 K [134].
A practical quantity to evaluate the connectivity is the active area fraction, \( A_f \) [21],

\[
A_f = \frac{\Delta \rho_{\text{ideal}}}{\Delta \rho(300K)} ,
\]

where,

\[
\Delta \rho_{\text{ideal}} = \rho_{\text{ideal}}(300K) - \rho_{\text{ideal}}(40K) \approx 9 \mu \Omega \text{ cm},
\]

is the resistivity of fully connected \( \text{MgB}_2 \) without any disorder [18], and

\[
\Delta \rho(300) = \rho(300K) - \rho(T_c).
\]

Figure 11. \( A_f \) dependence on sintering temperature. The short dashed line indicates \( A_f = 0.175 \). The upper left inset compares the resistivity of the \textit{in-situ} samples. The upper right inset compares the resistivity of the combined \textit{in-situ/ex-situ} samples [134].

Figure 11 compares the \( A_f \) of all the samples. All the samples show lower connectivity compared with those of ideal crystals, as indicated by the low \( A_f \) values. The \( A_f \) value of 750in is just 0.169, and high sintering temperature enhances the connectivity. It is ~ 0.26 for 850in. Higher sintering temperatures than 850 °C can improve the \( A_f \) slightly, which indicates that the connectivity is easy to improve for \textit{in-situ} samples. Although the MgO content is high in 1050in, its high \( A_f \) value is attributed to sufficient crystallization. However, its low magnetic field \( J_c \) was degraded by MgO. The combined \textit{in-situ/ex-situ} samples show rather low \( A_f \) values compared with the \textit{in-situ} samples. The phenomenon is consistent with the high resistivity of the \textit{in-situ/ex-situ} samples, as shown in the insets of Figure 11. The gradually improved
connectivity improves the $A_F$ values for the \textit{in-situ}/\textit{ex-situ} samples due to the improved solid state reaction. The self-field $J_c$ performances are also improved for 950inex and 1050inex.

The $J_c$ performance in the small-bundle region depends on a strong flux pinning force. The flux pinning centers could be lattice distortion, most types of defects, and grain boundaries [110, 137]. The temperature dependences of $H_{c2}$ and $H_{irr}$ determine the strength of the pinning force, as shown in Figure 12. The high field $J_c$ performance is in agreement with the $H_{c2}$ and $H_{irr}$ behavior. The 1050in sample shows the lowest $H_{c2}$ and $H_{irr}$ among all the samples. 850inex and 950inex show the highest $H_{c2}$ and $H_{irr}$, which are consistent with their high $J_c$ values in the small-bundle region. The \textit{ex-situ} powder induces strong disorder and proper crystallization, which are responsible for the high $H_{c2}$ and $H_{irr}$ values.

![Figure 12. $H_{c2}$ and $H_{irr}$ of (a) the \textit{in-situ} samples and (b) the combined \textit{in-situ}/\textit{ex-situ} samples [134].](image)

In summary, both connectivity and disorder show strong influences on the $J_c$ properties of MgB$_2$. The connectivity is responsible for the high effective charge carrier density, which determines the self-field $J_c$ performance. The strong flux pinning force induced by defects and disorder is responsible for the promising $J_c$ in high magnetic field. The enhanced $J_c$ performances of 850inex and 950inex are attributed to the optimized connectivity and disorder. The $J_c$ values obtained in this work are still far below the $J_d$ value, $\sim8.7\times10^8$ A/cm$^2$ for pure MgB$_2$. The $J_c$ improvement in MgB$_2$ should be explored based on the chemical doping effects and combined \textit{in-situ}/\textit{ex-situ} process.

4. Nano-SiC doped MgB$_2$ wires made by combined \textit{In-Situ/Ex-Situ} process

The combined \textit{in-situ}/\textit{ex-situ} process has proved to be a promising technique for the fabrication of practical MgB$_2$ wires. The $J_c$ of MgB$_2$ superconductors has been enhanced through many different kinds of dopants or additives [125], especially different carbon sources [75, 81,
In this work, a mixed in-situ/ex-situ technique was employed to develop nano-SiC doped MgB\(_2\) wires with high connectivity and strong flux pinning force to increase both the low and high field \(J_c\) properties [140]. The SiC particle size is another critical issue for introducing strong flux pinning forces into MgB\(_2\). The size of SiC used in this work is smaller than the sizes used in previous research, and the \(J_c\) dependence on sintering temperature also shows a very different trend [81, 104, 141, 142].

The powder-in-tube (PIT) process was employed to make practical MgB\(_2\) wires from a ball-milled mixture of Mg (99%), B (99%, amorphous), and SiC (< 15 nm). The sample fabrication and characterization are similar to the techniques mentioned for the pure samples in the last section.

![Figure 13. XRD patterns of nano-SiC doped MgB\(_2\)/Fe wires fabricated by (a) the in-situ technique and (b) the in-situ/ex-situ technique, with sintering at 750, 850, 950, and 1050 °C, respectively. All patterns were indexed with MgB\(_2\), MgO, MgSi, SiC, and Mg [140].](image)

Figure 13 shows the XRD patterns of the two batches of samples. According to the indexed XRD patterns, all samples show quite high purity of MgB\(_2\), with only small amounts of MgO and un-reacted Mg and SiC. The un-reacted Mg can be detected because of the high content of SiC in the raw materials [104, 115, 143]. The most interesting phase change relates to the change in the Mg\(_2\)Si content with sintering temperature. 750in shows very high Mg\(_2\)Si content, which decreases with increasing sintering temperature and becomes a trace peak in 1050in. However, more than a trace of Mg\(_2\)Si can only be found in samples sintered at lower temperature using the combined in-situ/ex-situ method, 750inex and 850inex. The variation of Mg\(_2\)Si content is an important signal of the C and Si distributions in the MgB\(_2\) matrix. Figure 14 shows SEM images of 850in and 850inex. The 850in sample contains large slits between MgB\(_2\) clusters due to the volume contraction during the in-situ sintering of Mg and B powders. The 850inex sample shows hard-packed MgB\(_2\) clusters because the ex-situ precursor is a course of nucleating centers and releases the strain of the in-situ MgB\(_2\).

The critical transition temperatures (\(T_c\)) of the two batches of samples are compared in Figure 15. It is found that the \(T_c\) values of the in-situ sintered samples are always slightly lower than those for the samples from the other batch, except for 1050in, and the \(T_c\) dependence on sintering temperature of the two batches of samples is exactly the same, which means that the
$T_c$ depends greatly on the sintering temperature, but not on the different techniques. However, the transition widths from the normal state to the superconducting state are quite different for the two batches of samples, as shown in the inset of Figure 15. The transition widths of the in-situ sintered samples are quite broad compared with those fabricated by the combined technique. The transition width is about 4 K for 750in and becomes 3 K for the 850in and 950in samples sintered at higher temperature due to the high crystallinity. It should be noted that the transition of 1050in shows a two-step behaviour, which may be attributed to the inhomogeneous carbon substitution effect or the inhomogeneous SiC distribution in the raw materials. The transition widths of all the samples made by the in-situ/ex-situ combined technique are 2.5 K, showing behaviour that is independent of the sintering temperature. This means that the crystallinity is increased through the in-situ/ex-situ combined technique because the precursor MgB$_2$ powder is a source of high quality nucleating centres for the newly formed MgB$_2$ during the solid-liquid reaction between the magnesium and the boron.

Figure 14. SEM photos of (a) 850in and (b) 850inex [140].

Figure 15. $T_c$ dependence on sintering temperature. The insets show the normalized magnetic moment dependence on the measuring temperature for the in-situ samples (upper) and for the in-situ/ex-situ samples (lower) [140].

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The $J_c$ dependence on the applied field is shown in Figure 16 for typical samples, which were measured at 5 K and 20 K, respectively. It should be noted that the $J_c$ dependence on sintering temperature in this work is totally different from previously reported results, because the solid-liquid reaction dynamics is different due to the small SiC particle size, less than 15 nm, which is much smaller than the particle sizes used before. The $J_c$ benefits from the high sintering temperature. 750in, 850in, and 750inex display non-competitive performance over the whole field range. 1050inex has very high low field $J_c$ values but its $J_c$ deteriorates with increasing magnetic field. The $J_c$ properties of 950in, 850inex, and 950inex show outstandingly high $J_c$ performances among all the samples. It is concluded that the in-situ/ex-situ combined technique only requires a lower sintering temperature to achieve high quality MgB$_2$ wires, which is very important for industrial application in terms of energy saving and equipment simplification.

The $J_c$ values of 750inex are double those of 750in at 5 K and 20 K over the measured magnetic field range. The inset of Figure 16 displays the low field performances at 20 K to avoid the influence of the flux jumping effect. 750in and 750inex show quite low $J_c$ values in lower magnetic field. 1050in and 850inex show competitive self-field $J_c$. The ball-milling process used to produce the ex-situ MgB$_2$ powder destroys the porous structure and enhances the density of MgB$_2$ fabricated by the in-situ/ex-situ combined process. This is because of the small particle size of SiC used in this work, which induces different reaction dynamics during the in-situ or in-situ/ex-situ processing [81, 104, 141, 142], so that the present $J_c$ dependence on sintering temperature is quite different from what has been previously reported. It is proposed that the liquid Mg reacts with SiC first to form Mg$_2$Si and releases free C at low sintering temperature. Then the Mg$_2$Si reacts with B to form MgB$_2$ and releases free Si at high sintering temperatures. Both C and Si have very small sizes and cannot be detected by XRD. The coherence length, $\xi$, of MgB$_2$ is anisotropic. $\xi_{ab}(0) = 3.7 - 12$ nm, and $\xi_{c}(0) = 1.6 - 3.6$ nm [110], which is shorter than the particle size of Mg$_2$Si. The Mg$_2$Si particles cannot be effective flux pinning centers, but are rather useless impurities in the MgB$_2$ matrix, which decrease the density of current carriers. However, the free C and Si can be very strong flux pinning centers because of their small sizes, which are responsible for the high $J_c$ performance in high magnetic fields. According to the collective pinning model [113], the $J_c$ performance in the low magnetic field region depends on the density of current carriers due to its weak field dependence, while the high magnetic field $J_c$ performance depends on the flux pinning force due to the increased high $H_{c2}$ and $H_{irr}$. The approximate $H_{ab}$ values are also indicated on the $J_c$ curves estimated at 20 K, as shown in the inset of Figure 16, where $H_{ab}$ is the crossover field from single-vortex to small-bundle pinning based on the collective pinning model. However, $H_{ab}$ has not been detected at 5 K due to the relatively high supercurrents [103].

The strength of the pinning force can be reflected by the dependence of $H_{c2}$ and $H_{irr}$ on the normalized temperature, as shown in Figure 17. Carbon substitution is one of the most effective methods to improve the $H_{c2}$ and $H_{irr}$ because of the increased scattering by C doping, and the increased scattering can also contribute to decreased $T_c$ and merging of the two gaps [144]. It should be noted that the $H_{c2}$ and $H_{irr}$ for 750in, 850in, and 750inex have their highest values at low temperature, which means a strong flux pinning force. The poor $J_c$ of these samples is attributed to the lower density of current carriers. Both 1050in and 1050inex show the lowest $H_{c2}$ and the lowest $H_{irr}$ among all the samples. 850in, 950in, 850inex, and 950inex show competitive $H_{c2}$ and $H_{irr}$ performances, which are responsible for their high $J_c$ values under high magnetic field.
Figure 16. $J_c$ at 5 K and 20 K. The inset indicates the $J_c$ behavior in low magnetic field at 20 K. $H_{sb}$, the crossover field from single-vortex to small-bundle pinning, is indicated by the dashed-dotted line at its probable position on the $J_c$ curves [140].

Figure 17. Comparison of $H_{c2}$ (solid symbols) and $H_{irr}$ (open symbols) for (a) MgB$_2$/Fe wires doped with nano-SiC and (b) MgB$_2$/Fe wires doped with nano-SiC, with sintering at 750, 850, 950, and 1050 °C, respectively [140].
In conclusion, high sintering temperature can improve the critical current density of small-particle-size SiC doped MgB$_2$. The two-step reactions between Mg, SiC, and B release free C and Si to form strong flux pinning centers. The current carrier density and flux pinning force are important factors in the improvement of the $J_c$ performance of nano-SiC doped MgB$_2$. The current carrier density determines the $J_c$ behavior in the single-vortex regime, where $J_c$ is independent of applied magnetic field. The flux pinning force determines the $J_c$ performance in the small-bundle pinning regime, where the doping induced defects are believed to act as flux pinning centers. Nano-SiC doped MgB$_2$/Fe wires fabricated by the combined process are worth ongoing research to develop optimized processing parameters for practical purposes.

5. Conclusions

The diffusion method can greatly improve the critical current density compared with the normal technique, which indicates that the critical current density greatly depends on the connectivity of MgB$_2$ grains. The combined process improves the connectivity of MgB$_2$ grains and the compactness of the superconducting core in wires, which induces high critical current density in zero field. The flux pinning force can also be improved by dopants for magnetic field application. Further research could focus on parameter optimization of the combined process to fabricate high quality MgB$_2$ wires.

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